

<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/584,142	LEE ET AL.
	Examiner	Art Unit
	Shick C. Hom	2666

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
370	349, 389,	1/8/2006	SH
370	392, 393,	1/8/2006	SH
370	410,	1/8/2006	SH
370/395.1, 395.2, 395.6, 395.61, 395.64, 395.3, 395.31		1/8/2006	SH

<b>Search Notes (continued)</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/584,142	LEE ET AL.
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<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
709	225, 227,	1/8/2006	SH
709	228, 230	1/8/2006	SH